Se	arch	Notes	

Application/Control No.	Applicant(s)/Patent un Reexamination	der
10/775,886	MATSUNAMI ET AL.	
Examiner	Art Unit	
Gregory P. Hein	2188	

SEARCHED			
Class	Subclass	Date	Examiner

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
IEEE Update Search - See attached	2/9/2006	GРН
East Update Search	2/9/2006	GРH
ACM Search - See attached	2/9/2006	GPH
PLUS Search	2/9/2006	GPH